

#### 650V Enhancement-mode GaN Transistor

#### **Description**

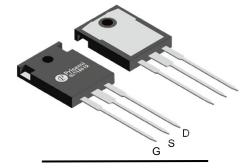
650V Normally-OFF GaN						
V <sub>DS</sub> (V)	$R_{DS(on)}(m\Omega)$	I <sub>DS</sub> (A)	Q <sub>G</sub> (nC)			
650	50	38	17			

#### **Feature**

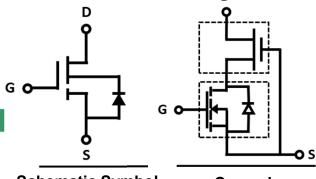
- > Easy to use, compatible with standard gate drivers
- ightharpoonup Excellent  $Q_G \times R_{DS(on)}$  figure of merit (FOM)
- ➤ Low Q<sub>RR</sub>, no free-wheeling diode required
- ➤ Low switching loss
- > RoHS compliant and Halogen-free
- ➤ Package:TO-247-3L

### **Applications**

- > High efficiency power supplies
- > Telecom and datacom
- Automotive
- Servo motors



TO-247-3L



**Schematic Symbol** 

Cascode Device Structure

### Absolute maximum rating@25°C

Rating		Symbol	Value	Units	
Drain-Source Voltage		V <sub>DSS</sub>	650	V	
Drain-Source Voltage-transient1)		V <sub>TDSS</sub>	800	V	
Gate-Source Voltage		V <sub>GSS</sub>	±20	V	
Drain Current Continuous	T <sub>C</sub> =25°C		38	Δ.	
Drain Current-Continuous	T <sub>C</sub> =100°C	l <sub>D</sub>	25	A	
Dules Dusin Comment (modes width 1000s)	T <sub>C</sub> =25°C	,	156	Δ	
Pulse Drain Current (pulse width: 100µs)	T <sub>C</sub> =150°C	I <sub>DM</sub>	101	A	
Maximum Power Dissipation		P <sub>D</sub>	139	W	
Operating and Storage Temperature Range		$T_{C}$ , $T_{J}$ , $T_{STG}$	-55~+150	℃	
Soldering Peak temperature		T <sub>CSOLD</sub>	260	°C	

#### Thermal characteristics

Parameter	Symbol	Тур.	Units
Thermal Resistance, Junction - Case	$R_{\theta JC}$	0.91	°C/W
Thermal Resistance, Junction - Ambient <sup>2)</sup>	$R_{\theta JA}$	50	°C/W

# Electrical characteristics per line@25°C (unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units	
Statistic Characteristics							
Drain-Source Voltage-Max	V <sub>DSS-Max</sub>	V <sub>GS</sub> = 0V	650	-	-	V	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V , I <sub>DS</sub> = 250μA	-	1000	-	V	
Total Drain Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> = 700V,V <sub>GS</sub> = 0V	-	10	30		
		V <sub>DS</sub> = 700V,V <sub>GS</sub> = 0V, T <sub>J</sub> =150°C	-	50	-	μA	
Gate Threshold Voltage	V <sub>GS(th)</sub>		3.0	4.0	5.0	V	
Gate Threshold Voltage Temperature Coefficient	$\triangle V_{GS(th)}/T_J$	$V_{GS} = V_{DS}$ , $I_D = 500 \mu A$	-	-11.3	-	mV/°C	
Gate-Source Leakage Current	I <sub>GSS</sub>	$V_{GS}$ = $\pm 20V$	-	-	±150	nA	
Otatia Dunin Common On Dunintary 2)	-	V <sub>GS</sub> = 12V, I <sub>D</sub> = 4A	-	50	65		
Static Drain-Source On-Resistance <sup>3)</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 12V, I <sub>D</sub> = 4A, T <sub>J</sub> =150°C	-	100	-	mΩ	
Dynamic Characteristics							
Input Capacitance	C <sub>iss</sub>		-	519	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = 400V, $V_{GS}$ = 0V, f= 1MHz	-	117	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	· ·····- <u>-</u>	-	2.7	-		
Effective Output Capacitance, Energy Related	C <sub>o(er)</sub>		-	175	-	pF	
Effective Output Capacitance, Time Related	C <sub>o(tr)</sub>	$V_{GS}$ =0V, $V_{DS}$ =0V to 400V	-	317	-		
Output Charge	Q <sub>oss</sub>		-	127	-	nC	
Total Gate Charge	Q <sub>g</sub>		-	17	-	nC	
Gate-Source Charge	$Q_{gs}$	$V_{GS}$ =0V to 12V, $V_{DS}$ =400V, $I_{D}$ =6A	-	4.6	-		
Gate-Drain Charge	$Q_{gd}$	Ü	-	5.6	-		
Turn-on Delay Time	t <sub>d(on)</sub>		-	44	-		
Turn-on Rise Time	t <sub>r</sub>	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V to 12V,	-	16	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D=10A$ , $R_G=40\Omega$ ,	-	40	-		
Turn-Off Fall Time	t <sub>f</sub>		-	12	-		
Reverse Device Characteristics			•	•			
	V <sub>SD</sub>	V <sub>GS</sub> = 0V,I <sub>S</sub> = 12.5A	-	1.3	-		
Diode Forward Voltage		V <sub>GS</sub> = 0V,I <sub>S</sub> = 25A	-	1.9	-	V	
		V <sub>GS</sub> = 0V,I <sub>S</sub> = 25A, T <sub>J</sub> =150°C	-	3.0	-		
Reverse Recovery Time	t <sub>rr</sub>	I <sub>S</sub> =25A, V <sub>DD</sub> =400V,	-	43	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>	d <sub>i</sub> /d <sub>t</sub> =1000A/µs, V <sub>GS</sub> =0V	_	127	_	nC	

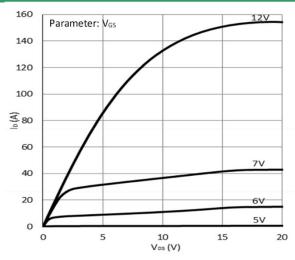
Notes:

<sup>1.</sup> Off-state spike duty cycle < 0.01, spike duration < 2us

<sup>2.</sup> Device on one layer epoxy PCB for drain connection (vertical and without air stream cooling, with 6cm² copper area and 70µm thickness)

<sup>3.</sup> Dynamic on-resistance; see Figure 17 and 18 for test circuit and configurations

#### **Typical Characteristics**



Parameter: V<sub>GS</sub>

100

80

40

40

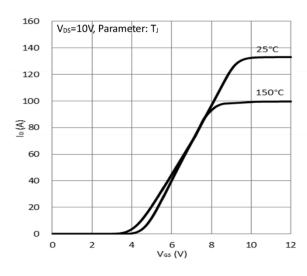
20

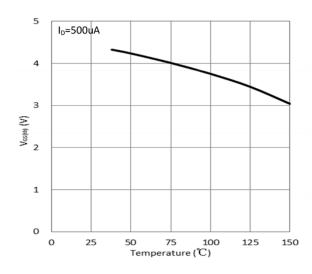
5v

V<sub>cs</sub>(V)

Figure 1. Typical Output Characteristics T₁=25°C

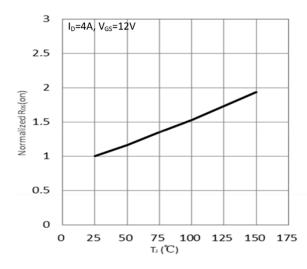
Figure 2. Typical Output Characteristics T₁=150°C





**Figure 3. Typical Transfer Characteristics** 

Figure 4. V<sub>GS(th)</sub> Vs Temperature Characteristics



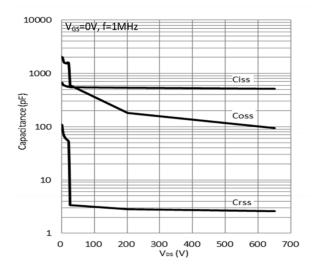
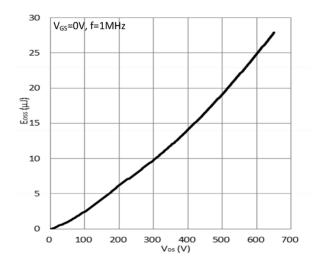


Figure 5. Normalized On-resistance

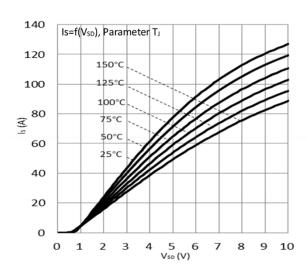
Figure 6. Typical Capacitance



140 120 2100 80 60 40 20 0 100 200 300 400 500 600 700 Vos (V)

Figure 7. Typical Coss Stored Energy

Figure 8. Typical Qoss



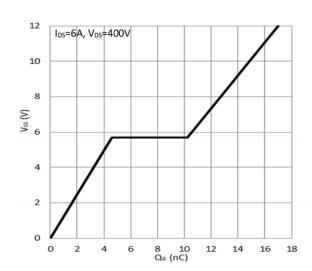
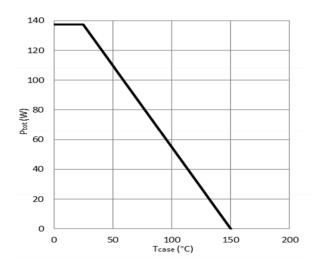


Figure 9. Forward Characteristic of Rev. Diode

Figure 10. Typical Gate Charge



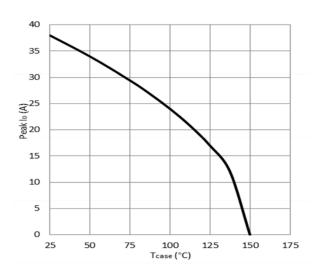
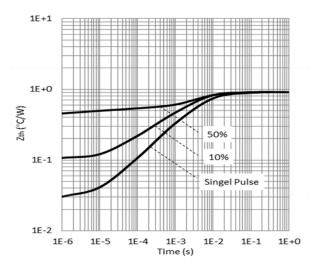


Figure 11. Power Dissipation

Figure 12. Current Derating



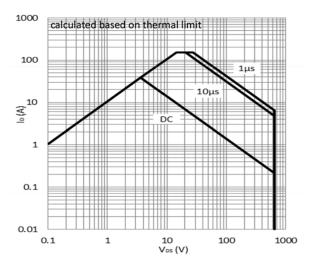


Figure 13. Transient Thermal Resistance

Figure 14. Safe Operating Area T<sub>C</sub>=25℃

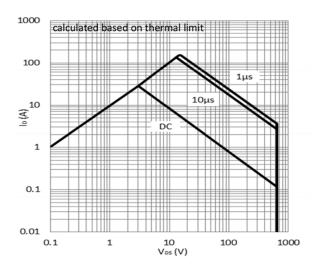


Figure 15. Safe Operating Area  $T_C=80^{\circ}$ 

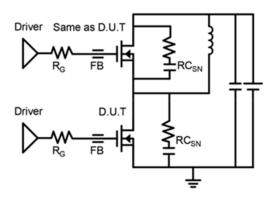


Figure 15. Switching Time Test Circuit

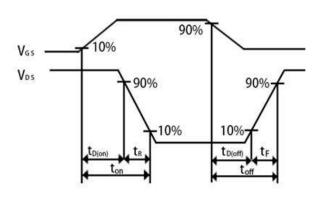


Figure 16. Switching Time Waveform

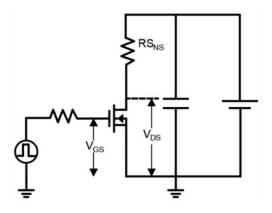


Figure 17. Dynamic RDS(on) Test Circuit

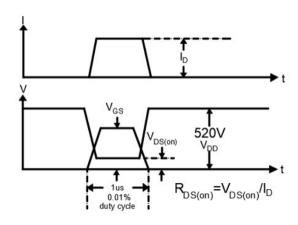


Figure 18. Dynamic  $R_{DS(on)}$  Waveform

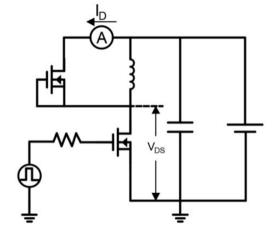


Figure 19. Diode Characteristic Test Circuits

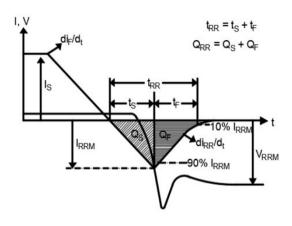
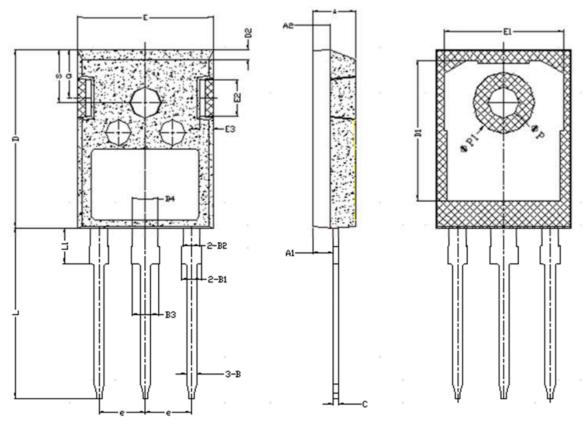


Figure 20. Diode Recovery Waveform

## **Product Dimension (TO-247-3L)**



CVAADOL	Millimeter				
SYMBOL	Min	Nom	Max		
А	4.60	4.90	5.20		
A1	2.20	2.40	2.60		
В	0.90	1.20	1.40		
B1	1.75	2.05	2.35		
B2	1.75	1.95	2.15		
В3	2.80	3.00	3.35		
B4	2.80	2.95	3.15		
С	0.50	0.60	0.70		
D	20.60	21.00	21.30		
D1	16.00	17.00	18.00		
Е	15.50	15.80	16.10		
E1	13.00	13.80	14.70		
E2	3.80	4.50	5.30		
E3	0.80	1.70	2.60		
Е	5.20	5.40	5.7		
L	19.00	20.00	20.50		
L1	3.90	4.30	4.60		
ФР	3.30	3.50	3.70		
ФР1	7.00	7.20	7.40		
Q	5.20	5.60	6.00		
S	5.80	6.20	6.60		

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